Anbotek Product Safety Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1 Page1of80

FCC SAR Test Report

Client Name : Seeed Technology Co., Ltd.

200

Address

9F, G3 Building, TCL International E City, Zhongshanyuan Road, Nanshan District, Shenzhen, Guangdong Province, P.R.C

Product Name

AWS Button

Date

Mar. 26, 2020



Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1 Page2of80

Contents

1.	10 M 10 M 10 M	5
2.	General Information	6
	2.1 Client Information	6
	2. 2 Description of Equipment Under Test (EUT)	6
	2.3 Device Category and SAR Limits	8
	2. 4 Applied Standard	8
	2.5 Environment of Test Site	8
	2. 6 Test Configuration	
3.	Specific Absorption Rate (SAR)	9
	3.1 Introduction	9
	3.2 SAR Definition	9
4.	SAR Measurement System	10
	4.1 E-Field Probe	11
	4. 2 Data Acquisition Electronics (DAE)	11
	4.3 Robot	12
	4. 4 Measurement Server	13
	4.5 Phantom	13
	4.6 Device Holder	
	4.7 Data Storage and Evaluation	16
5.		18
6.	Tissue Simulating Liquids	19
7.	AD to the work of the second to the second to the second te second te second te second te second te second te s	20
8.	EUT Testing Position	22
	8.1 Body Worn Position	22
9.	Measurement Procedures	
	9.1 Spatial Peak SAR Evaluation	
	9.2 Power Reference Measurement	
	9.3 Area Scan Procedures	24
	9.4 Zoom Scan Procedures	25
	9.5 Volume Scan Procedures	26
	9.6 Power Drift Monitoring	26
10	9.3 Area Scan Procedures. 9.4 Zoom Scan Procedures. 9.5 Volume Scan Procedures. 9.6 Power Drift Monitoring. D. Conducted Power. Antenna Location.	27
11	. Antenna Location	30
12	2. SAR Test Results Summary	31
13	3. Measurement Uncertainty	32
Ar	2. SAR Test Results Summary 3. Measurement Uncertainty ppendix A. EUT Photos and Test Setup Photos	33
Ar	ppendix B. Plots of SAR System Check	34
Ar	ppendix A. EOT Photos and Test Setup Photos ppendix B. Plots of SAR System Check ppendix C. Plots of SAR Test Data ppendix D. DASX System Calibration Certificate	36
Ar	ppendix D. DASY System Calibration Certificate	40

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com

Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1 Page3of80

TEST REPORT

	Seeed Technology Co., Ltd.
nbote	Seeed Technology Co., Ltd.
Anto	AWS Button
. 1	Seeed IoT Button for AWS
ek.	Seeed Studio
botel	Input: DC 5V, 2A
	hen hote hote h

Test Standard(s) : IEEE 1528:2013; IEC 62209-2:2010; FCC 47 CFR Part 2 (2.1093:2013);

ANSI/IEEE C95.1:2005;Reference FCC KDBs;

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the IEEE 1528:2013, IEC 62209-2:2010, FCC 47 CFR Part 2 (2.1093:2013), ANSI/IEEE C95.1:2005, and Reference FCC KDBsrequirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Receipt Date of Test

Prepared By

Mar.02, 2020 Mar.02, 2020~Mar.09, 2020

King Kong Jin

(Engineer / Kingkong Jin)

Bibs Thank

Reviewer

(Supervisor / Bibo Zhang)

(Manager / Tom Chen)

Approved & Authorized Signer

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com

Report No.: 18220WC00009805FCC ID: Z4TSEEEDAWSBU1Page4of80

Version

Version No.	Date	Description				
Danbore 01	Mar.09, 2020	Original				
Anbola An	obotek Anbotek	Anbon Anbotek Anbotek Anbotek				
otek Anbo	Anbotek Anbote	Anbotek Anbotek Anbotek Anbotek Anbotek				
nbota Antotek	Anbotes Anbo	otek Anbotek Anbotek Anbotek Anbotek				
Anborek Anbore	k Anbolo pa	nbotek Anbotek Anbotek Anbotek Anbotek				
- onbotek Ant	oles Anbo	Anbotek Anbourek Anbotek Anbotek An				

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com



1. Statement of Compliance

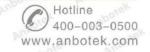
The maximum results of Specific Absorption Rate (SAR) found during testing are as follows.

<Highest SAR Summary>

From Pond	Highest Reported 1g-SAR(W/Kg)	SAR Test Limit	
Frequency Band	Body-worn(5mm)	(W/Kg)	
WIFI 2.4GHz	0.517	anbor Al wote	
WIFI 5.2GHz	0.503	1.6	
WIFI 5.8GHz	0.333	Anboten Ant	
Test Result	PASS	K subotek I	

This device is in compliance with Specific Absorption Rate (SAR) for general population/uncontrolled exposure limits (1.6 W/kg) specified in KDB 447498 D01 v06, 2015 and ANSI/IEEE C95.1-2005, and had been tested in accordance with the measurement methods and procedures specified in IEEE 1528-2013

Shenzhen Anbotek Compliance Laboratory Limited





2. General Information

2.1 Client Information

Applicant	:	Seeed Technology Co., Ltd.	
Address	:	9F, G3 Building, TCL International E City, Zhongshanyuan Road, Nanshan District, Shenzhen, Guangdong Province, P.R.C	otek.
Manufacturer	:	Seeed Technology Co., Ltd.	bote
Address	:	9F, G3 Building, TCL International E City, Zhongshanyuan Road, Nanshan District, Shenzhen, Guangdong Province, P.R.C	Anb
Factory	:	Seeed Technology Co., Ltd.	9
Address	:	9F, G3 Building, TCL International E City, Zhongshanyuan Road, Nanshan District, Shenzhen, Guangdong Province, P.R.C	otok

2. 2 Description of Equipment Under Test (EUT)

Product Name	:	AWS Button	tek obotek Anboten Anu otek
Model No.	:	Seeed IoT Button for AWS	Sandon tek anborek Anbore And Lotek
Trade Mark	:	Seeed Studio	Anbornek anborek Anborn And hotek
Test Power Supply	:	Input: DC 5V, 2A	Anbo otek onbotek Anboi An
e c		Number of Channel:	WiFi 2.4G: 11 Channels for 802.11b/ g/ n(HT20) 7 Channels for 802.11n(HT40) BLE: 40 Channels
1		And and a solution of official and a solution of the solution	WiFi 5.2G: 4 Channels for 802.11a WiFi 5.8G: 5 Channels for 802.11a
		Antek Anbotek Anbotek	WiFi 2.4G: 802.11b/ g/ n(HT20) 2412-2462MHz 802.11n(HT40) 2422-2452MHz
Product	:	Operation Frequency:	BLE: 2402-2480MHz
Description		nboten Anbo	WiFi 5.2G: 5180MHz~5240MHz WiFi 5.8G: 5745MHz~5825MHz
		Modulation Type:	WiFi 2.4G: 802.11b CCK; 802.11g/n OFDM BLE: GFSK WiFi 5.1G: OFDM with BPSK/QPSK/16QAM/64QAM/256QAM WiFi 5.8G: OFDM with
		too, by votek b	BPSK/QPSK/16QAM/64QAM/256QAM

Shenzhen Anbotek Compliance Laboratory Limited

Report No.:	10 Notes 10 Notes	V. LOT DIT	age7of80
	Antenna Type:	PCB Antenna	
	Anbeten Anbe	WiFi 2.4G: 4.1 dBi	Anboten
	Antonno Coin/Dook):	BLE: 4.1 dBi	
	Antenna Gain(Peak):	WiFi 5.2G: 3.6 dBi	
	Ant tek abo	WiFi 5.8G: 2 dBi	

Remark: 1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1 Page8of80

2.3 Device Category and SAR Limits

This device belongs to portable device category because its radiating structure is allowed to be used within 20 centimeters of the body of the user. Limit for General Population/Uncontrolled exposure should be applied for this device, it is 1.6 W/kg as averaged over any 1 gram of tissue.

2. 4 Applied Standard

The Specific Absorption Rate (SAR) testing specification, method, and procedure for this device is in accordance with the following standards:

- FCC 47 CFR Part 2 (2.1093:2013)
- ANSI/IEEE C95.1:2005
- IEEE Std 1528:2013
- KDB 865664 D01 SAR Measurement 100 MHz to 6 GHz v01r04
- KDB 865664 D02 RF Exposure Reporting v01r02
- KDB 447498 D01 General RF Exposure Guidance v06
- KDB248227 D01 802 11 Wi-Fi SAR v02r02
- KDB941225 D01 3G SAR Procedures v03r01
- KDB 941225 D05 SAR for LTE Devicesv02r05
- KDB 941225 D06 Hotspot SARv02r01
- KDB648474 D04 Handset SAR v01r03

2.5 Environment of Test Site

Items	Required	Actual
Temperature (°C)	18-25	22~23
Humidity (%RH)	30-70	55~65

2.6 Test Configuration

For WIFI SAR testing, engineering testing software installed on the EUT can provide continuous transmitting RF signal.

Shenzhen Anbotek Compliance Laboratory Limited



3. Specific Absorption Rate (SAR)

3.1 Introduction

SAR is related to the rate at which energy is absorbed per unit mass in an object exposed to a radio field. The SAR distribution in a biological body is complicated and is usually carried out by experimental techniques or numerical modeling. The standard recommends limits for two tiers of groups, occupational/controlled and general population/uncontrolled, based on a person's awareness and ability to exercise control over his or her exposure. In general, occupational/controlled limits the limits general exposure higher than are population/uncontrolled.

3.2 SAR Definition

The SAR definition is the time derivative (rate) of the incremental energy (dW) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dv) of a given density (ρ). The equation description is as below:

$$SAR = \frac{d}{dt} \left(\frac{dW}{dm} \right) = \frac{d}{dt} \left(\frac{dW}{\rho dv} \right)$$

SAR is expressed in units of Watts per kilogram (W/kg)

SAR measurement can be either related to the temperature elevation in tissue by

$$SAR = C\left(\frac{\delta T}{\delta t}\right)$$

Where: C is the specific head capacity, δT is the temperature rise and δ tisthe exposure duration, or related to the electrical field in the tissue by

$$SAR = \frac{\sigma |E|^2}{\rho}$$

Where: σ is the conductivity of the tissue, ρ is the mass density of the tissue and E is the RMS electrical field strength.

However for evaluating SAR of low power transmitter, electrical field measurement is typically applied.

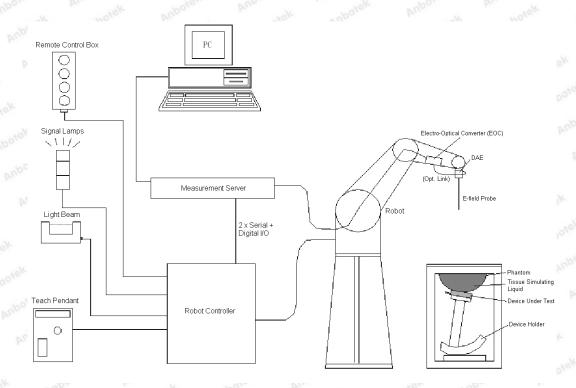
Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: Z4TSEEEDAWSBU1 Page10of80

4. SAR Measurement System



DASY System Configurations

The DASYsystem for performance compliance tests is illustrated above graphically. This system consists of the following items:

- > A standard high precision 6-axis robot with controller, a teach pendant and software
- > A data acquisition electronic (DAE) attached to the robot arm extension
- A dosimetric probe equipped with an optical surface detector system
- The electro-optical converter (EOC) performs the conversion between optical and electrical signals
- A measurement server performs the time critical tasks such as signal filtering, control of the robot operation and fast movement interrupts.
- > A probe alignment unit which improves the accuracy of the probe positioning
- A computer operating Windows XP
- DASY software
- Remove control with teach pendant and additional circuitry for robot safety such as warming lamps, etc.
- The SAM twin phantom
- A device holder
- Tissue simulating liquid

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: Z4TSEEEDAWSBU1

Page11of80

Dipole for evaluating the proper functioning of the system

components are described in details in the following sub-sections.

4.1 E-Field Probe

The SAR measurement is conducted with the dosimetric probe (manufactured by SPEAG). The probe is specially designed and calibrated for use in liquid with high permittivity. The dosimetric probe has special calibration in liquid at different frequency. This probe has a built in optical surface detection system to prevent from collision with phantom.

<ex3dv4 prob<="" th=""><th>e> he atek anbore And</th><th>boten Anbo</th></ex3dv4>	e> he atek anbore And	boten Anbo
Construction	Symmetrical design with triangular core Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., DGBE)	
Frequency	10 MHz to 6 GHz; Linearity: ± 0.2 dB	P.O.
Directivity	 ± 0.3 dB in HSL (rotation around probe axis) ± 0.5 dB in tissue material (rotation normal to probe axis) 	
Dynamic Range	10 μ W/g to 100 mW/g; Linearity: ± 0.2 dB (noise: typically < 1 μ W/g)	Photo of EX3DV4
Dimensions	Overall length: 330 mm (Tip: 20 mm) Tip diameter: 2.5 mm (Body: 12 mm) Typical distance from probe tip to dipole centers: 1 mm	Anborek Anborek Anborek

E-Field Probe Specification

E-Field Probe Calibration

Each probe needs to be calibrated according to a dosimetric assessment procedure with accuracy better than \pm 10%. The spherical isotropy shall be evaluated and within \pm 0.25dB. The sensitivity parameters (NormX, NormY, and NormZ), the diode compression parameter (DCP) and the conversion factor (ConvF) of the probe are tested. The calibration data can be referred to appendix C of this report.

4. 2 Data Acquisition Electronics (DAE)

The data acquisition electronics (DAE) consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the measurement server is

Shenzhen Anbotek Compliance Laboratory Limited

Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1 Page12of80

accomplished through an optical downlink for data and status information as well as an optical uplink for commands and the clock.

The input impedance of the DAE is 200MOhm; the inputs are symmetrical and floating. Common mode rejection is above 80dB.



Photo of DAE

4.3 **Robot**

The SPEAG DASY system uses the high precision robots (DASY5: TX60XL) type from Stäubli SA (France). For the 6-axis controllersystem, the robot controller version (DASY5: CS8c) from Stäubli is used. The Stäubli robot series have many features that are important for our application:

- High precision (repeatability ±0.035 mm)
- High reliability (industrial design)
- > Jerk-free straight movements
- Low ELF interference (the closed metallic construction shields against motor control fields)



Photo of DASY5

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1 Page13of80

4. 4 Measurement Server

The measurement server is based on a PC/104 CPU board with CPU (DASY5: 400 MHz, Intel Celeron), chipdisk (DASY5: 128 MB), RAM (DASY5: 128 MB). The necessary circuits for communication with the DAE electronic box, as well as the 16 bit AD converter system for optical detection and digital I/O interface are contained on the DASY I/O board, which is directly connected to the PC/104 bus of the CPU board.

The measurement server performs all the real-time data evaluation for field measurements and surface detection, controls robot movements and handles safety operations.



Photo of Server for DASY5

4.5 Phantom

<SAM Twin Phantom>

Shell Thickness	2 ± 0.2 mm;
0	Center ear point: 6 ± 0.2 mm
Filling Volume	Approx. 25 liters
Dimensions	Length: 1000 mm; Width: 500 mm;
	Height: adjustable feet
Measurement	Left Hand, Right Hand, Flat
Areas	Phantom
	or Ar hotek Antorer Anu
	bole An alek N

Photo of SAM Phantom

The bottom plate contains three pair of bolts for locking the device holder. The device holder positions are adjusted to the standard measurement positions in the three sections. A white cover is provided to tap the phantom during off-periods to prevent water evaporation and changes in the liquid parameters. On the phantom top, three reference markers are provided to identify the phantom position with respect to the robot.

Shenzhen Anbotek Compliance Laboratory Limited



 Product Safety

 Report No.: 18220WC00009805

 FCC ID: Z4TSEEEDAWSBU1

 <ELI4 Phantom>

Anbotek

Shell Thickness	2 ± 0.2 mm (sagging: <1%)	a
Filling Volume	Approx. 30 liters	
Dimensions	Major ellipse axis: 600 mm	
	Minor axis:400 mm	20
	ote Alle potek Anboten Anbe	800
	abote Ann alek unbotes Anou	
	Anboten Anbo tek enbotek Anb	
	anbatek Anboi Ali hotek Anv dek anboi	
	Photo of ELI4 Phantom	310
	And at hotek hipo	

The ELI4 phantom is intended for compliance testing of handheld and body-mounted wireless devices in the frequency range of 30 MHz to 6 GHz. ELI4 is fully compatible with standard and all known tissue simulating liquids.

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com



Page14of80

Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1

Page15of80

4.6 Device Holder

The SAR in the phantom is approximately inversely proportional to the square of the distance between the source and the liquid surface. For a source at 5 mm distance, a positioning uncertainty of ± 0.5 mm would produce a SAR uncertainty of $\pm 20\%$. Accurate device positioning is therefore crucial for accurate and repeatable measurements. The positions in which the devices must be measured are defined by the standards.

The DASY device holder is designed to cope with different positions given in the standard. It has two scales for the device rotation (with respect to the body axis) and the device inclination (with respect to the line between the ear reference points). The rotation center for both scales is the ear reference point (ERP). Thus the device needs no repositioning when changing the angles.

The DASY device holder is constructed of low-loss POM material having the following dielectric parameters: relative permittivity ε = 3 and loss tangent δ = 0.02. The amount of dielectric material has been reduced in the closest vicinity of the device, since measurements have suggested that the influence of the clamp on the test results could thus be lowered.



Device Holder

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: Z4TSEEEDAWSBU1

Page16of80

4.7 Data Storage and Evaluation

Data Storage

The DASY software stores the assessed data from the data acquisition electronics as raw data (in microvolt readings from the probe sensors), together with all the necessary software parameters for the data evaluation (probe calibration data, liquid parameters and device frequency and modulation data) in measurement files. The post-processing software evaluates the desired unit and format for output each time the data is visualized or exported. This allows verification of the complete software setup even after the measurement and allows correction of erroneous parameter settings. For example, if a measurement has been performed with an incorrect crest factor parameter in the device setup, the parameter can be corrected afterwards and the data can be reevaluated.

The measured data can be visualized or exported in different units or formats, depending on the selected probe type (e.g., [V/m], [A/m], [mW/g]). Some of these units are not available in certain situations or give meaningless results, e.g., a SAR-output in a non-lose media, will always be zero. Raw data can also be exported to perform the evaluation with other software packages.

Data Evaluation

The DASY post-processing software (SEMCAD) automatically executes the following procedures to calculate the field units from the microvolt readings at the probe connector. The parameters used in the evaluation are stored in the configuration modules of the software:

Probe parameters:	- Sensitivity		Normi, aio, ai1, ai2		
ek Anbu ek	- Conversion factor	Con	vFi		
potek Anbor	- Diode compression poir	nt And	dcpi		
Device parameters:	- Frequency		foot		
And stek subotek	- Crest factor		cf		
Media parameters:	- Conductivity		σ priboti		
Anbors Atr	- Density	ρ			

These parameters must be set correctly in the software. They can be found in the component documents or they can be imported into the software from the configuration files issued for the DASY components. In the direct measuring mode of the multi-meter option, the parameters of the actual system setup are used. In the scan visualization and export modes, the parameters stored in the corresponding document files are used.

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power.

Shenzhen Anbotek Compliance Laboratory Limited

Anbotek

FCC ID: Z4TSEEEDAWSBU1 Page17of80

The formula for each channel can be given as:

$$\mathbf{V}_i = \mathbf{U}_i + \mathbf{U}_i^2 \cdot \frac{\mathbf{cf}}{\mathbf{dcp}_i}$$

with V_i = compensated signal of channel i, (i = x, y, z)

 U_i = input signal of channel i, (i = x, y, z)

cf = crest factor of exciting field (DASY parameter)

dcp_i = diode compression point (DASY parameter)

From the compensated input signals, the primary field data for each channel can be evaluated:

E-field Probes: $E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}}$

H-field Probes: $H_i = \sqrt{V_i} \cdot \frac{a_{i0} + a_{i1}f + a_{i2}f^2}{f}$

with V_i = compensated signal of channel i,(i = x, y, z) Norm_i= sensor sensitivity of channel i, (i = x, y, z), $\mu V/(V/m)^2$ for E-field Probes

ConvF= sensitivity enhancement in solution

aij= sensor sensitivity factors for H-field probes

f = carrier frequency [GHz]

 E_i = electric field strength of channel i in V/m

H_i= magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

$$SAR = E_{tot}^2 \cdot \frac{\sigma}{\rho \cdot 1000}$$

with SAR = local specific absorption rate in mW/g

Etot= total field strength in V/m

 σ = conductivity in [mho/m] or [Siemens/m]

 ρ = equivalent tissue density in g/cm³

Note that the density is set to 1, to account for actual head tissue density rather than the density of the tissue simulating liquid.

Shenzhen Anbotek Compliance Laboratory Limited



5. Test Equipment List

Manufacturar	None of Equipment	Trues (Mandal		Calibi	ation
Manufacturer	Name of Equipment	Type/Model	Serial Number	Last Cal.	Due Date
SPEAG	2450MHz System Validation Kit	D2450V2	910	Jun 15,2018	Jun 14,2021
SPEAG	5GHz System Validation Kit	D5GHzV2	1160	Oct 02,2018	Oct 01,2021
SPEAG	Data Acquisition Electronics	DAE4	387	Sept.03,2019	Sept.02,2020
SPEAG	Dosimetric E-Field Probe	EX3DV4	7396	May 06,2019	May 06,2020
Agilent	ENA Series Network Analyzer	E5071C	MY46317418	May. 22, 2019	May. 21, 2020
SPEAG	DAK	DAK-3.5	1226	NCR	NCR
SPEAG	ELI Phantom	QDOVA004AA	2058	NCR	NCR
AR	Amplifier	ZHL-42W	QA1118004	NCR	NCR
Agilent	Power Meter	N1914A	MY50001102	Nov. 06, 2019	Nov. 05, 2020
Agilent	Power Sensor	N8481H	MY51240001	Nov. 06, 2019	Nov. 05, 2020
R&S	Spectrum Analyzer	N9020A	MY51170037	May. 22, 2019	May. 21, 2020
Agilent	Signal Generation	N5182A	MY48180656	May. 22, 2019	May. 21, 2020
Worken	Directional Coupler	0110A05601O- 10	COM5BNW1A2	May. 22, 2019	May. 21, 2020

FCC ID: Z4TSEEEDAWSB

Note:

1. The calibration certificate of DASY can be referred to appendix C of this report.

- The dipole calibration interval can be extended to 3 years with justification. The dipoles are also not physically damaged, or repaired during the interval.
- 3. The Insertion Loss calibration of Dual Directional Coupler and Attenuator were characterized via the network analyzer and compensated during system check.
- . The dielectric probe kit was calibrated via the network analyzer, with the specified procedure (calibrated in pure water) and calibration kit (standard) short circuit, before the dielectric measurement. The specific procedure and calibration kit are provided by Agilent.
- 5. In system check we need to monitor the level on the power meter, and adjust the power amplifier level to have precise power level to the dipole; the measured SAR will be normalized to 1W input power according to the ratio of 1W to the input power to the dipole. For system check, the calibration of the power amplifier is deemed not critically required for correct measurement; the power meter is critical and we do have calibration for it

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com



Page18of80

Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1

Page19of80

6. Tissue Simulating Liquids

For the measurement of the field distribution inside the SAM phantom with DASY, the phantom must be filled with around 25 liters of homogeneous body tissue simulating liquid. For head SAR testing, the liquid height from the ear reference point (ERP) of the phantom to the liquid top surface is larger than 15 cm, which is shown in Fig. 6.1. For body SAR testing, the liquid height from the center of the flat phantom to the liquid top surface is larger than 15 cm, which is shown as followed:



Photo of Liquid Height for Body SAR

The following table gives the recipes for tissue simulating liquid.

Frequency (MHz)	Water (%)	Sugar (%)	Cellulose (%)	Salt (%)	Prevento I (%)	DGBE (%)	Conductivity (σ)	Permittivity (εr)
				For Bo	dy			
5000	78.6	Augo O	10.7	0 nbot	10.7	oter 0	6.00	48.2

The following table shows the measuring results for simulating liquid.

	Measured	Target	Tissue		Measure	ed Tissue)	Liquid	
Tissue Type	Frequenc y (MHz)	٤r	σ	٤r	Dev. (%)	σ	Dev. (%)	Temp.(℃)	Test Date
2450	2450	52.7	1.95	52.12	-1.10	1.93	-1.03	22.1	2020-03-05
5000	5200	48.20	6.00	46.36	-3.82	6.15	2.50	21.8	2020-03-06

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1

Page20of80

7. System Verification Procedures

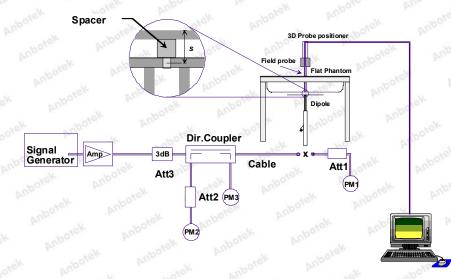
Each DASY system is equipped with one or more system validation kits. These units, together with the predefined measurement procedures within the DASY software, enable the user to conduct the system performance check and system validation. System validation kit includes a dipole, tripod holder to fix it underneath the flat phantom and a corresponding distance holder.

Purpose of System Performance check

The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check be performed prior to any usage of the system in order to guarantee reproducible results. The system performance check uses normal SAR measurements in a simplified setup with a well characterized source. This setup was selected to give a high sensitivity to all parameters that might fail or vary over time. The system check does not intend to replace the calibration of the components, but indicates situations where the system uncertainty is exceeded due to drift or failure.

System Setup

In the simplified setup for system evaluation, the EUT is replaced by a calibrated dipole and the power source is replaced by a continuous wave that comes from a signal generator. The calibrated dipole must be placed beneath the flat phantom section of the SAM twin phantom with the correct distance holder. The distance holder should touch the phantom surface with a light pressure at the reference marking and be oriented parallel to the long side of the phantom. The equipment setup is shown below:



System Setup for System Evaluation

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com



FCC ID: Z4TSEEEDAWSBU1

Page21of80



Photo of Dipole Setup

Validation Results

Comparing to the original SAR value provided by SPEAG, the verification data should be within its specification of 10%. The table below shows the target SAR and measured SAR after normalized to 1W input power. It indicates that the system performance check can meet the variation criterion and the plots can be referred to Appendix A of this report.

Frequenc y (MHz)	Liquid Type	Power fed onto reference dipole (mW)	Targeted SAR (W/kg)	Measured SAR (W/kg)	Normalized SAR (W/kg)	Deviatio n (%)	Test Date
2450	Body	250	51.8	12.74	50.96	-1.62	2020-03-05
5000	Body	100	77.8	7.91	79.1	1.67	2020-03-06

Target and Measurement SAR after Normalized

Shenzhen Anbotek Compliance Laboratory Limited



Anbotek Product Safety

FCC ID: Z4TSEEEDAWSBU1 Page22of80

8. EUT Testing Position

8.1 Body Worn Position

wojugud ield

Body-worn operating configurations are tested with the belt-clips and holsters attached to the device and positioned against a flat phantom in a normal use configuration. Per KDB 648474 D04, body-worn accessory exposure is typically related to voice mode operations when handsets are carried in body-worn accessories. Thebody-worn accessory procedures in FCC KDB 447498 D01 v06, 2015 should be used to test for body-worn accessory SARcompliance, without a headset connected to it. This enables the test results for such configuration to be compatible withthat required for hotspot mode when the body-worn accessory test separation distance is greater than or equal to that required for hotspot mode, when applicable. When the reported SAR for body-worn accessory, measured without aheadset connected to the handset is < 1.2 W/kg, the highest reported SAR configuration for that wireless mode andfrequency band should be repeated for that body-worn accessory with a handset attached to the handset.

Accessories for body-worn operation configurations are divided into two categories: those that do not contain metallic components and those that do contain metallic components and those that do contain metallic components. Whenmultiple accessories that do not contain metallic components are supplied with the device, the device is tested with onlythe accessory that dictates the closest spacing to the body. Then multiple accessories that contain metallic components are test with the device with each accessory. If multiple accessories share an identical metallic component (i.e. the same metallic belt-chip used with different holsters with no other metallic components) only the accessory that dictates the closest spacing to the body is tested.

molnend leig

Body Worn Position

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1 Page23of80

9. Measurement Procedures

The measurement procedures are as follows:

- (a) Use base station simulator (if applicable) or engineering software to transmit RF power continuously (continuous Tx) in the middle channel.
- (b) Keep EUT to radiate maximum output power or 100% duty factor (if applicable)
- (c) Measure output power through RF cable and power meter.
- (d) Place the EUT in the positions as setup photos demonstrates.
- (e) Set scan area, grid size and other setting on the DASY software.
- (f) Measure SAR transmitting at the middle channel for all applicable exposure positions.
- (g) Identify the exposure position and device configuration resulting the highest SAR
- (h) Measure SAR at the lowest and highest channels at the worst exposure position and device configuration if applicable.

According to the test standard, the recommended procedure for assessing the peak spatial-average SAR value consists of the following steps:

- (a) Power reference measurement
- (b) Area scan
- (c) Zoom scan
- (d) Power drift measurement

9.1 Spatial Peak SAR Evaluation

The procedure for spatial peak SAR evaluation has been implemented according to the test standard. It can be conducted for 1g and 10g, as well as for user-specific masses. The DASY software includes all numerical procedures necessary to evaluate the spatial peak SAR value.

The base for the evaluation is a "cube" measurement. The measured volume must include the 1g and 10g cubes with the highest averaged SAR values. For that purpose, the center of the measured volume is aligned to the interpolated peak SAR value of a previously performed area scan.

The entire evaluation of the spatial peak values is performed within the post-processing engine (SEMCAD). The system always gives the maximum values for the 1g and 10g cubes. The algorithm to find the cube with highest averaged SAR is divided into the following stages:

- (a) Extraction of the measured data (grid and values) from the Zoom Scan
- (b) Calculation of the SAR value at every measurement point based on all stored data (A/D values and measurement parameters)
- (c) Generation of a high-resolution mesh within the measured volume
- (d) Interpolation of all measured values form the measurement grid to the high-resolution grid
- (e) Extrapolation of the entire 3-D field distribution to the phantom surface over the distance from

Shenzhen Anbotek Compliance Laboratory Limited



Page24of80

sensor to surface

Calculation of the averaged SAR within masses of 1g and 10g (f)

9.2 Power Reference Measurement

The Power Reference Measurement and Power Drift Measurements are for monitoring the power drift of the device under test in the batch process. The minimum distance of probe sensors to surface determines the closest measurement point to phantom surface. This distance cannot be smaller than the distance of sensor calibration points to probe tip as defined in the probe properties.

9.3 Area Scan Procedures

The area scan is used as a fast scan in two dimensions to find the area of high field values, before doing a fine measurement around the hot spot. The sophisticated interpolation routines implemented in DASY software can find the maximum found in the scanned area, within a range of the global maximum. The range (in dB0 is specified in the standards for compliance testing. For example, a 2 dB range is required in IEEE standard 1528 and IEC 62209 standards, whereby 3 dB is a requirement when compliance is assessed in accordance with the ARIB standard (Japan), if only one zoom scan follows the area scan, then only the absolute maximum will be taken as reference. For cases where multiple maximums are detected, the number of zoom scans has to be increased accordingly.

Area scan parameters extracted from FCC KDB 865664 D01 SAR measurement 100 MHz to 6 GHz.

	\leq 3 GHz	> 3 GHz
Maximum distance from closest measurement point (geometric center of probe sensors) to phantom surface	$5 \pm 1 \text{ mm}$	$\frac{1}{2} \cdot \delta \cdot \ln(2) \pm 0.5 \text{ mm}$
Maximum probe angle from probe axis to phantom surface normal at the measurement location	$30^{\circ} \pm 1^{\circ}$	$20^{\circ} \pm 1^{\circ}$
	\leq 2 GHz: \leq 15 mm 2 - 3 GHz: \leq 12 mm	$3 - 4$ GHz: ≤ 12 mm $4 - 6$ GHz: ≤ 10 mm
Maximum area scan spatial resolution: Δx_{Area} , Δy_{Area}	When the x or y dimension of measurement plane orientation the measurement resolution n x or y dimension of the test d measurement point on the test	on, is smaller than the above, must be \leq the corresponding evice with at least one

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: Z4TSEEEDAWSBU1

Page25of80

9. 4 Zoom Scan Procedures

Zoom scans are used assess the peak spatial SAR values within a cubic averaging volume containing 1 gram and 10gram of simulated tissue. The zoom scan measures points (refer to table below) within a cube shoes base faces are centered on the maxima found in a preceding area scan job within the same procedure. When the measurement is done, the zoom scan evaluates the averaged SAR for 1 gram and 10 gram and displays these values next to the job's label. Zoom scan parameters extracted from FCC KDB 865664 D01 SAR measurement 100 MHz to 6 GHz.

			\leq 3 GHz	> 3 GHz
-tok	vapo.	per alt	bole And	stek anbo
Maximum zoom scan s	patial reso	lution: Δx_{Zoom} , Δy_{Zoom}	≤ 2 GHz: ≤ 8 mm 2 - 3 GHz: ≤ 5 mm [*]	$3 - 4 \text{ GHz:} \le 5 \text{ mm}^*$ $4 - 6 \text{ GHz:} \le 4 \text{ mm}^*$
	uniform	grid: $\Delta z_{Zoom}(n)$	\leq 5 mm	$3 - 4$ GHz: ≤ 4 mm $4 - 5$ GHz: ≤ 3 mm $5 - 6$ GHz: ≤ 2 mm
Maximum zoom scan spatial resolution, normal to phantom surface	graded	$\Delta z_{Zoom}(1)$: between 1 st two points closest to phantom surface	\leq 4 mm	3 – 4 GHz: ≤ 3 mm 4 – 5 GHz: ≤ 2.5 mm 5 – 6 GHz: ≤ 2 mm
	grid	$\Delta z_{Zoom}(n>1)$: between subsequent points	≤1.5·∆z	Zoom(n-1)
Minimum zoom scan volume	x, y, z	·	≥ 30 mm	3 – 4 GHz: ≥ 28 mm 4 – 5 GHz: ≥ 25 mm 5 – 6 GHz: ≥ 22 mm

Note: δ is the penetration depth of a plane-wave at normal incidence to the tissue medium; see draft standard IEEE P1528-2011 for details.

When zoom scan is required and the <u>reported</u> SAR from the area scan based 1-g SAR estimation procedures of KDB 447498 is ≤ 1.4 W/kg, ≤ 8 mm, ≤ 7 mm and ≤ 5 mm zoom scan resolution may be applied, respectively, for 2 GHz to 3 GHz, 3 GHz to 4 GHz and 4 GHz to 6 GHz.

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: Z4TSEEEDAWSBU1

Page26of80

9.5 Volume Scan Procedures

The volume scan is used for assess overlapping SAR distributions for antennas transmitting in different frequency bands. It is equivalent to an oversized zoom scan used in standalone measurements. The measurement volume will be used to enclose all the simultaneous transmitting antennas. For antennas transmitting simultaneously in different frequency bands, the volume scan is measured separately in each frequency band. In order to sum correctly to compute the 1g aggregateSAR, the EUT remain in the same test position for all measurements and all volume scan use the same spatial resolution and grid spacing. When all volume scan were completed, the software, SEMCAD postprocessor can combine and subsequently superpose these measurement data to calculating the multiband SAR.

9.6 Power Drift Monitoring

All SAR testing is under the EUT install full charged battery and transmit maximum output power. In DASY measurement software, the power reference measurement and power drift measurement procedures are used for monitoring the power drift of EUT during SAR test. Both these procedures measure the field at a specified reference position before and after the SAR testing. The software will calculate the field difference in dB. If the power drift more than 5%, the SAR will be retested.

Shenzhen Anbotek Compliance Laboratory Limited



10. Conducted Power

Mode	Channel	Frequency (MHz)	Conducted Output Power(Peak, dBm)	Tune-up power(dBm)	Test Rate Data
802.11b	nbor 1	2412	14.7	15.2	1 Mbps
	6	2437	14.87	15.2	1 Mbps
	11	2462	15.1	15.2	1 Mbps
	1 abote	2412	13.47	14.0	6 Mbps
802.11g	6	2437	13.46	14.0	6 Mbps
	11	2462	13.97	14.0	6 Mbps
	loote 1	2412	11.68	12.0	MCS0
802.11n(20MHz)	6	2437	11.6	12.0	MCS0
	11	2462	11.59	12.0	MCS0
	3	2422	12.05	12.1	MCS0
802.11n(40MHz)	6	2437	11.86	12.1	MCS0
	9	2452	12.12	12.1	MCS0

<WLAN 2.4GHz Conducted Power>

<WIFI 5.2GHz Conducted Power>

Mode	Channel	Frequency (MHz)	Conducted Output Power(dBm)	Tune-up power(dBm)	Test Rate Data
	36	5180	13.54	14.2	MCS0
11a	40 × 40	5200	13.91	14.2	MCS0
	48	5240	14.14	14.2	MCS0

<WIFI 5.8GHz Conducted Power>

Mode	Channel	Frequency (MHz)	Conducted Output Power(dBm)	Tune-up power(dBm)	Test Rate Data
	149	5745	13.44	13.5	MCS0
11a	157	5785	12.59	13.5	MCS0
	165	5825	13.17	13.5	MCS0

Note:

1. Per KDB 447498 D01 v06, 2015, the test distance is 5mm.

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1

Page28of80

5	Mode	Frequency (GHz)	Maximum Conducted Output Power	Tune-up Power (dBm)	Max. Power (mW)	Test distance (mm)	Result	exclusion thresholds for 1-g SAR
4	802.11b	2450	15.10	15.2	33.11	5	10.37	3.0
	802.11a	5240	14.14	14.2	26.30	5 poter	12.04	3.0
1000	802.11a	5745	13.44	13.5	22.39	5	10.73	3.0

Base on the result of note1, RF exposure evaluation of 2.4GWIFI, 5.2G/5.8WIFI) mode is required.

2. Per KDB 248227 D01, choose the highest output power channel to test SAR and determine further SAR exclusion.

3. Per KDB 248227 D01, In the 5GHz band, separate SAR procedures are applied to DSSS and OFDM configurations to simplify DSSS test requirements. SAR is not required for the following 2.4/5GHz OFDM conditions:

When KDB Publication 447498 SAR test exclusion applies to the OFDM configuration.
 When the highest reported SAR for DSSS is adjusted by the ratio of OFDM to DSSS specified maximum output power and the adjusted SAR is ≤ 1.2 W/kg.

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00009805 FCC ID: Z4TSEEEDAWSBU1 Page29of80

Mode	ode Channel Frequency (MHz)		Conducted Power (dBm)	Tune-up power(dBm)	
	00	2402	2.88	antone 3 time	
BLE-GFSK	19	2440	1.38	2	
	39	2480	1.12	2 otek Ant	

<Bluetooth Conducted Power>

Note:

Per KDB 447498 D01v05r02, the 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances \leq 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] $\cdot [\sqrt{f(GHz)}] \le 3.0$

for 1-g SAR and \leq 7.5 for 10-g extremity SAR

f(GHz) is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation

The result is rounded to one decimal place for comparison

Bluetooth Max Power (dBm)	Separation Distance (mm)	Frequency (GHz)	exclusion thresholds
2.88	Anbore 5 botek	2.48	0.630

Per KDB 447498 D01, when the minimum test separation distance is ≤ 5 mm, a distance of 5 mm is applied to determine SAR test exclusion. The test exclusion threshold is 0.630 which is ≤ 3 , SAR testing is not required.

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00009805FCC ID: Z4TSEEEDAWSBU1Page30of80

11. Antenna Location

WIFI/BT ANT.

POmm BUT Right Edge EUT 45mn 95mn

EUT Bottom Edge

EUT Left Edge EUT

EUT BACK VIEW

AntennasFrontBackTop SideBottom SideLeft Side	Right Side	
BT&WLAN <25mm	>25mm	

Positions for SAR tests; Hotspot mode									
Antennas	Front	Back	Top Side	Bottom Side	Left Side	Right Side			
BT&WLAN	Yes	Yes	No No	No No	Yes	No			

General Note: Referring to KDB 941225 D06, When the overall device length and width are <9cm*5cm, the test distance is 5mm. SAR must be measured for all sides and surfaces with a transmitting antenna located with 25mm from that surface or edge.

Shenzhen Anbotek Compliance Laboratory Limited

Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1

Page31of80

12. SAR Test Results Summary

General Note:

1. Per KDB 447498 D01 v06, 2015, the reported SAR is the measured SAR value adjusted for maximum tune-up tolerance.

Scaling Factor = tune-up limit power (mW) / EUT RF power (mW), where tune-up limit is the maximum rated power among all production units.

Reported SAR(W/kg)= Measured SAR(W/kg)* Scaling Factor

2. Per KDB 447498 D01 v06, 2015, for each exposure position, if the highest output channel reported SAR≤0.8W/kg, other channels SAR testing are not necessary

Plot	Band	Mode	Test	Gap		Freq. (MHz	е	Tune-U p	Scalin g	r	Measure d	d
No.			Position	(cm))	Power (dBm)	Limit (dBm)	Factor	Drift (dB)	SAR _{1g} (W/kg)	SAR ₁₉ (W/kg)
#1	WIFI 2.4GHz	b	Front	0.5	11	2462	15.1	15.2	1.007	0.09	0.514	0.517
00	WIFI 2.4GHz	b	Back	0.5	11	2462	15.1	15.2	1.007	0.06	0.474	0.477
Pupo,	WIFI 2.4GHz	b	Life Side	0.5	11	2462	15.1	15.2	1.007	0.08	0.486	0.489
#2	WIFI 5.2GHz	a	Front	0.5	48	5240	14.14	14.2	1.004	-0.11	0.501	0.503
	WIFI 5.2GHz	а	Back	0.5	48	5240	14.14	14.2	1.004	-0.07	0.476	0.478
N	WIFI 5.2GHz	а	Life Side	0.5	48	5240	14.14	14.2	1.004	0.15	0.489	0.491
#3	WIFI 5.8GHz	а	Front	0.5	149	5745	13.44	13.5	1.004	0.10	0.332	0.333
0,0	WIFI 5.8GHz	а	Back	0.5	149	5745	13.44	13.5	1.004	-0.07	0.313	0.314
Anbote	WIFI 5.8GHz	а	Life Side	0.5	149	5745	13.44	13.5	1.004	0.06	0.311	0.312

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: Z4TSEEEDAWSBU1 Page32of80

13. Measurement Uncertainty

Per KDB865664D01 SAR Measurement 100MHz to 6GHz, when the highest measured 1-g SAR within a frequency band is <1.5W/Kg, the extensive SAR measurement uncertainty analysis described in IEC 62209-2:2010 is not required in SAR reports submitted for equipment approval.

Shenzhen Anbotek Compliance Laboratory Limited





Appendix A. EUT Photos and Test Setup Photos



Top (5mm)

Body Back(5mm)



Left side (5mm)

Shenzhen Anbotek Compliance Laboratory Limited





Appendix B. Plots of SAR System Check

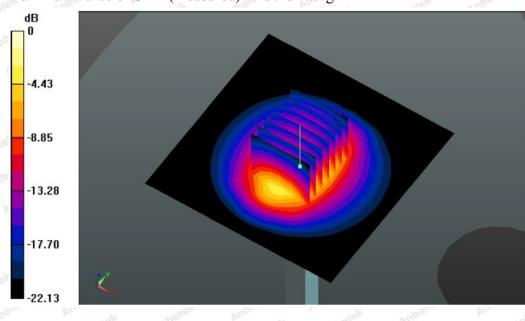
System Performance Check at 2450 MHz

Date:2020-03-05 DUT: Dipole 2450 MHz; Type: D2450V2; Serial: 910 Communication System: CW; Frequency: 2450 MHz;Duty Cycle: 1:1 Medium parameters used (interpolated): f = 2450 MHz; $\sigma = 1.93$ S/m; $\epsilon r = 52.12$; $\rho = 1000$ kg/m3 Phantom section: Flat Section

DASY5 Configuration:

Probe: EX3DV4 - SN7396; ConvF(7.53, 7.53, 7.53); Calibrated: 05,06.2019; Sensor-Surface: 3mm (Mechanical Surface Detection) Electronics: DAE4 Sn387; Calibrated: 03.09.2019 Phantom: SAM 1; Type: SAM; Measurement SW: DASY52, Version 52.8 (1); SEMCAD X Version 14.6.5 (6469)

Area Scan (61x91x1):Measurement grid: dx=10.00 mm, dy=10.00 mm Maximum value of SAR (interpolated) = 19.225 mW/g Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm Reference Value = 84.153 V/m; Power Drift = 0.05dB Peak SAR (extrapolated) = 26.125 W/kg SAR(1 g) = 12.74 mW/g; SAR(10 g) = 5.69 mW/g Maximum value of SAR (measured) = 19.18mW/g



Shenzhen Anbotek Compliance Laboratory Limited





5200MHz System Check

DUT: Dipole 5 GHz; Type: D5GHzV2; Serial: D5GHzV2 - SN:1160

Communication System: UID 0, CW; Frequency: 5200 MHz; Duty Cycle: 1:1 Medium parameters used: f = 5200 MHz; σ = 6.15 S/m; ϵ_r = 46.36; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(4.93, 4.93, 4.93); Calibrated: 05.06.2019;
- Sensor-Surface: 1.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: 03.09.2019
- Phantom: SAM2; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (7); SEMCAD X Version 14.6.10 (7164)

Configuration/Pin=100mW/Zoom Scan (7x7x7)/Cube 0:Measurement grid: dx=4mm, dy=4mm, dz=1.4mm

Reference Value = 49.005 V/m; Power Drift = 0.08 dB

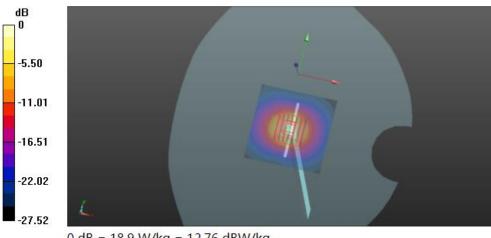
Peak SAR (extrapolated) = 31.8 W/kg

SAR(1 g) = 7.91 W/kg; SAR(10 g) = 2.17 W/kg

Maximum value of SAR (measured) = 19.4 W/kg

Configuration/Pin=100mW/Area Scan (71x71x1):Interpolated grid: dx=1.000 mm, dy=1.000 mm

Maximum value of SAR (interpolated) = 18.9 W/kg



0 dB = 18.9 W/kg = 12.76 dBW/kg

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1 Page36of80

Appendix C. Plots of SAR Test Data

#1

Date:2020-03-05

WIFI 2.4G _802.11b_Body Frant _Ch11

Communication System: UID 0, wifi (fcc) (0); Frequency: 2462 MHz;Duty Cycle: 1:1

Medium parameters used (interpolated): f = 2462 MHz; σ = 1.97 S/m; ϵ_r = 51.89; ρ = 1000 kg/m³

Phantom section: Flat Section

DASY5 Configuration:

•Probe: EX3DV4 - SN7396; ConvF(7.53, 7.53, 7.53); Calibrated: 05,06.2019;

•Sensor-Surface: 4mm (Mechanical Surface Detection)

•Electronics: DAE4 Sn387; Calibrated: 03.09.2019

•Phantom: SAM 1; Type: SAM;

•Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

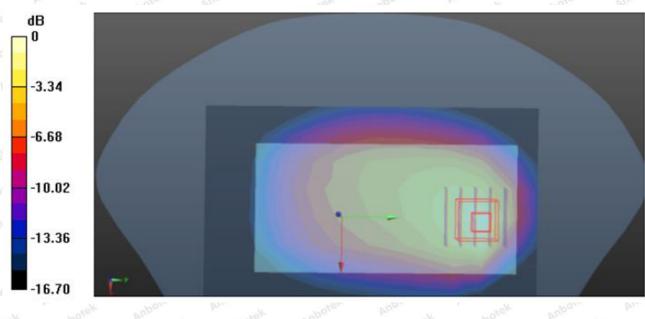
BODY Front /Area Scan (33x17x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (measured) = 0.574 W/kg

BODY Front /Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 13.4 V/m; Power Drift = 0.09 dB Peak SAR (extrapolated) = 0.515 W/kg SAR(1 g) = 0.514 W/kg; SAR(10 g) = 0.258 W/kg

Maximum value of SAR (measured) = 0.605 W/kg



Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com



#2

Anbotek Product Safety

Date: 2020-03-06

WIFI 5.2G _Body Front_Ch48

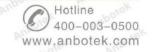
Communication System: UID 0, 802.11a (0); Frequency: 5240MHz; Duty Cycle: 1:1 Medium parameters used (interpolated): f = 5240 MHz; σ = 6.23 S/m; ϵ_r = 46.13; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

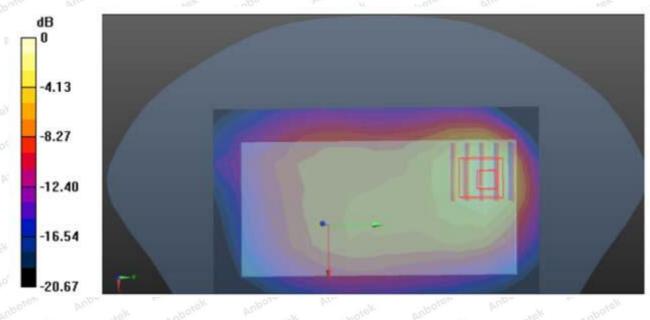
- Probe: EX3DV4 SN7396; ConvF(4.93, 4.93, 4.93); Calibrated: 05.06.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: 03.09.2019
- Phantom: SAM2; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (7); SEMCAD X Version 14.6.10 (7164)

BODY Front /Area Scan (9x13x1):Measurement grid: dx=10mm, dy=10mm Maximum value of SAR (measured) = 0.521W/kg BODY Front /Zoom Scan (8x8x12)/Cube 0:Measurement grid: dx=4mm, dy=4mm, dz=2mm Reference Value = 17.76 V/m; Power Drift = -0.11 dB Peak SAR (extrapolated) = 0.536 W/kg SAR(1 g) = 0.501 W/kg; SAR(10 g) = 0.312 W/kg Maximum value of SAR (measured) = 0.537 W/kg

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00009805 FCC ID: Z4TSEEEDAWSBU1 Page38of80



#3

Date: 2020-03-06

WIFI 5.8G _Body Front_Ch149

Communication System: UID 0, 802.11a (0); Frequency: 5745MHz; Duty Cycle: 1:1 Medium parameters used (interpolated): f = 5745 MHz; σ = 6.23 S/m; ϵ_r = 46.13; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(4.93, 4.93, 4.93); Calibrated: 05.06.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: 03.09.2019
- Phantom: SAM2; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (7); SEMCAD X Version 14.6.10 (7164)

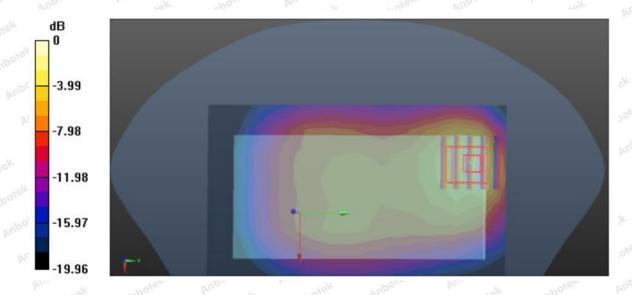
BODY Front /Area Scan (9x13x1):Measurement grid: dx=10mm, dy=10mm Maximum value of SAR (measured) =0.478 W/kg

BODY Front /Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm Reference Value = 19.26 V/m; Power Drift = 0.10 dB Peak SAR (extrapolated) = 0.439 W/kg

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00009805 FCC ID: Z4TSEEEDAWSBU1 Page39of80 SAR(1 g) = 0.332 W/kg; SAR(10 g) = 0.141 W/kg Maximum value of SAR (measured) = 0.342 W/kg Page39of80



Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com



FCC ID: Z4TSEEEDAWSBU1

Page40of80

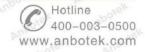
Appendix D. DASY System Calibration Certificate

Beijing, 100191, China 0-62304633-2209 <u>cchinattl.cn</u> Certificate No: Z19- SN:7396 7-03 Procedures for Dosimetric E-field Probes 19	68716
SN:7396 7-03 Procedures for Dosimetric E-field Probes	68716
7-03 Procedures for Dosimetric E-field Probes	
7-03 Procedures for Dosimetric E-field Probes	
Procedures for Dosimetric E-field Probes	
Procedures for Dosimetric E-field Probes	
19	
closed laboratory facility: environment	temperature(22±3) $\mathbb C$ and
	Scheduled Calibration
20-Jun-18 (CTTL, No.J18X07447)	Jun-19
20-Jun-18 (CTTL, No.J18X07447)	Jun-19
20-Jun-18 (CTTL, No.J18X07447)	Jun-19
13-Mar-19(CTTL.No.J19X01547)	Mar-20
13-Mar-19(CTTL, No.J19X01548)	Mar-20
26-Sep-18(SPEAG,No.EX3-7433 Sep18)	Sep-19
13-Dec-18(SPEAG, No.DAE4-549_Dec18)	Dec -19
Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
27-Jun-18 (CTTL, No.J18X04776)	Jun-19
13-Jan-19 (CTTL, No.J19X00285)	Jan -20
Function	Signature
SAR Test Engineer	AT(E)
SAR Test Engineer	#末书5
SAR Project Leader	200
Chart Tojour Louder	000
	alibration) al Date(Calibrated by, Certificate No.) 20-Jun-18 (CTTL, No.J18X07447) 20-Jun-18 (CTTL, No.J18X07447) 20-Jun-18 (CTTL, No.J18X07447) 13-Mar-19(CTTL, No.J19X01547) 13-Mar-19(CTTL, No.J19X01548) 26-Sep-18(SPEAG, No.DAE4-549_Dec18) 13-Dec-18(SPEAG, No.DAE4-549_Dec18) 13-Dec-18(SPEAG, No.DAE4-549_Dec18) Cal Date(Calibrated by, Certificate No.) 27-Jun-18 (CTTL, No.J18X04776) 13-Jan-19 (CTTL, No.J19X00285) Function SAR Test Engineer

Certificate No: Z19-68716

Page 1 of 11

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1





 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mail: cttl@chinattl.com
 <u>Http://www.chinattl.cn</u>

Glossary:

TSL	tissue simulating liquid
NORMx,y,z	sensitivity in free space
ConvF	sensitivity in TSL / NORMx,y,z
DCP	diode compression point
CF	crest factor (1/duty cycle) of the RF signal
A,B,C,D	modulation dependent linearization parameters
Polarization Φ	Φ rotation around probe axis
Polarization θ	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i
	θ=0 is normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)", February 2005
- c) IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010

d) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization θ=0 (f≤900MHz in TEM-cell; f>1800MHz: waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)x, y, z = NORMx, y, z* frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics.
- Ax,y,z; Bx,y,z; Cx,y,z;VRx,y,z:A,B,C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f≤800MHz) and inside waveguide using analytical field distributions based on power measurements for f >800MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty valued are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from±50MHz to±100MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

Certificate No: Z18-98671

Page 2 of 11

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: Z4TSEEEDAWSBU1





 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mail: cttl@chinatl.com
 <u>Http://www.chinattl.cn</u>

Probe EX3DV4

SN: 7396

Calibrated: May 06, 2019

Calibrated for DASY/EASY Systems

(Note: non-compatible with DASY2 system!)

Certificate No: Z19-68716

Page 3 of 11

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1



 Add: No.51 Xueyuan Road. Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mail: ettl@chinattl.com
 <u>Http://www.chinattl.cn</u>

DASY/EASY - Parameters of Probe: EX3DV4 - SN: 7396

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm(µV/(V/m) ²) ^A	0.54	0.53	0.50	±10.0%
DCP(mV) ^B	97.8	104.5	102.5	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dBõV	C	D dB	VR mV	Unc ^E (k=2)	
0 CW	0		X	0.0	0.0	1.0	0.00	199.9	±2.4%
		Y	0.0	0.0	1.0		203.3		
		Z	0.0	0.0	1.0		195.0	1	

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X, Y, Z do not affect the E²-field uncertainty inside TSL (see Page 5 and Page 6).
 ^B Numerical linearization parameter: uncertainty not required.
 ^E Uncertainly is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

Certificate No: Z18-98671

Page 4 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



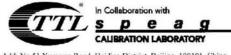
Page43of80

Product Safety

Anbotek

Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1



 Add: No.51 Xucyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mail: cttl@chinattl.com
 <u>Http://www.chinattl.cn</u>

DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz] ^c	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unct. (k=2)
750	41.9	0.89	9.82	9.82	9.82	0.30	0.85	±12.1%
835	41.5	0.90	9.71	9.71	9.71	0.15	1.36	±12.1%
900	41.5	0.97	9.87	9.87	9.87	0.16	1.37	±12.1%
1750	40.1	1.37	8.61	8.61	8.61	0.25	1.04	±12.1%
1900	40.0	1.40	8.13	8.13	8.13	0.24	1.01	±12.1%
2100	39.8	1.49	8.14	8.14	8.14	0.24	1.04	±12.1%
2300	39.5	1.67	7.85	7.85	7.85	0.40	0.75	±12.1%
2450	39.2	1.80	7.57	7.57	7.57	0.50	0.75	±12.1%
2600	39.0	1.96	7.38	7.38	7.38	0.64	0.68	±12.1%
5250	35.9	4.71	5.33	5.33	5.33	0.45	1.30	±13.3%
5600	35.5	5.07	4.89	4.89	4.89	0.45	1.35	±13.3%
5750	35.4	5.22	4.92	4.92	4.92	0.45	1.45	±13.3%

^c Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

^F At frequency below 3 GHz, the validity of tissue parameters (ε and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ε and σ) is restricted to ±5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters. ^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

Certificate No: Z18-98671

Page 5 of 11

Shenzhen Anbotek Compliance Laboratory Limited



Product Safety

Anbotek

Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1



 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, Chin

 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mail: cttl@chinattl.com
 <u>Http://www.chinattl.cn</u>

DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Calibration Parameter Determined in Body Tissue Simulating Media

f [MHz] ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unct. (k=2)
750	55.5	0.96	10.09	10.09	10.09	0.30	0.90	±12.1%
835	55.2	0.97	9.88	9.88	9.88	0.19	1.32	±12.1%
900	55.0	1.05	9.82	9.82	9.82	0.23	1.15	±12.1%
1750	53.4	1.49	8.24	8.24	8.24	0.24	1.06	±12.1%
1900	53.3	1.52	7.97	7.97	7.97	0.19	1.24	±12.1%
2100	53.2	1.62	8.18	8.18	8.18	0.19	1.39	±12.1%
2300	52.9	1.81	7.88	7.88	7.88	0.55	0.80	±12.1%
2450	52.7	1.95	7.53	7.53	7.53	0.46	0.89	±12.1%
2600	52.5	2.16	7.38	7.38	7.38	0.52	0.80	±12.1%
5250	48.9	5.36	4.93	4.93	4.93	0.45	1.80	±13.3%
5600	48.5	5.77	4.19	4.19	4.19	0.48	1.90	±13.3%
5750	48.3	5.94	4.52	4.52	4.52	0.48	1.95	±13.3%

^c Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

^F At frequency below 3 GHz, the validity of tissue parameters (ε and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ε and σ) is restricted to ±5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters. ^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

Certificate No: Z18-98671

Page 6 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com



Page45of80

Product Safety

Anbotek

Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1

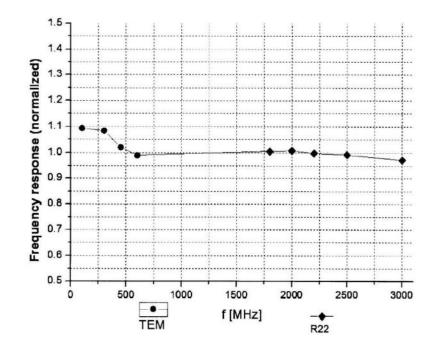


 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tcl: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mail: cttl@chinattl.com
 <u>Http://www.chinattl.cn</u>

Frequency Response of E-Field (TEM-Cell: ifi110 EXX, Waveguide: R22)





Certificate No: Z18-98671

Page 7 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



Page46of80

Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1





 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

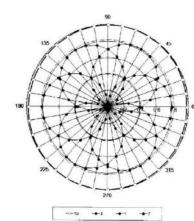
 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

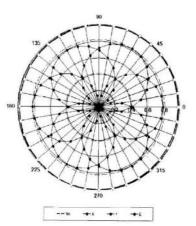
 E-mail: ettl@chinattl.com
 <u>Http://www.chinattl.cn</u>

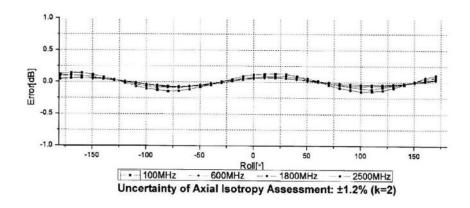
Receiving Pattern (Φ), θ=0°

f=600 MHz, TEM

f=1800 MHz, R22







Certificate No: Z18-98671

Page 8 of 11

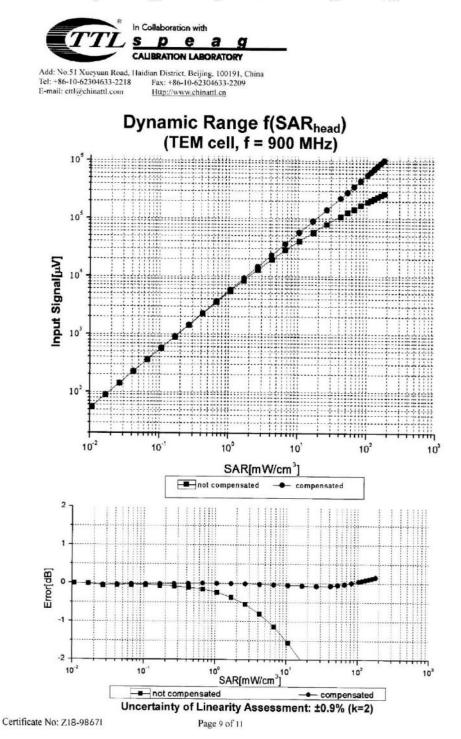
Shenzhen Anbotek Compliance Laboratory Limited



Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1

Page48of80



Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com

Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1

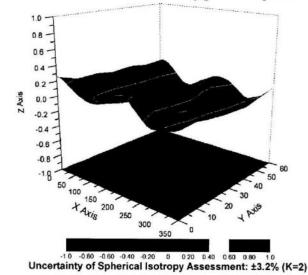


Add: No.51 Xueyuan Road, 1 Tel: +86-10-62304633-2218 an District, Beijing, 100191, China uan Road, Haidi Fax: +86-10-62304633-2209 E-mail: cttl@chinattl.com Http://www.chinattl.cn

Conversion Factor Assessment

f=900 MHz, WGLS R9(H_convF) f=1750 MHz, WGLS R22(H_convF) 4.00 30.00 3.50 25.00 3.00 2.50 2.00 2.00 2.00 20.00 WIGWNIARS 10.00 1.00 5.00 0.50 0.00 0.00 20 0 40 10 100 0 20 30 40 50 z[mm] z[mm] --measured -----analytical

Deviation from Isotropy in Liquid



Certificate No: Z18-98671

Page 10 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



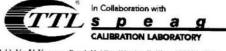
Page49of80

60

70

Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1



 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mail: ettl@chinatl.com
 <u>Http://www.chinattl.cn</u>

DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Other Probe Parameters

Sensor Arrangement	Triangular	
Connector Angle (°)	156.9	
Mechanical Surface Detection Mode	enabled	
Optical Surface Detection Mode	disable	
Probe Overall Length	337mm	
Probe Body Diameter	10mm	
Tip Length	9mn 2.5mn	
Tip Diameter		
Probe Tip to Sensor X Calibration Point	1mm	
Probe Tip to Sensor Y Calibration Point	1mm	
Probe Tip to Sensor Z Calibration Point	1mm	
Recommended Measurement Distance from Surface	1.4mm	

Certificate No: Z18-98671

Page 11 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com



Page50of80



FCC ID: Z4TSEEEDAWSBU1

Page51of80

Schmid & Partner Engineering AG

speaq

Zeughausstrasse 43, 8004 Zurich, Switzerland Phone +41 44 245 9700, Fax +41 44 245 9779 info@speag.com, http://www.speag.com

IMPORTANT NOTICE

USAGE OF THE DAE 4

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE4 unit is closed using a screw, over tightening the screw may cause the threads inside the DAE to wear out.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration, remove the batteries and pack the DAE in an antistatic bag. This antistatic bag shall then be packed into a larger box or container which protects the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, the customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the annual calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

DASY Configuration Files: Since the exact values of the DAE input resistances, as measured during the calibration procedure of a DAE unit, are not used by the DASY software, a nominal value of 200 MOhm is given in the corresponding configuration file.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the Estop assembly is allowed by certified SPEAG personnel only and is part of the annual calibration procedure.

Important Note:

To prevent damage of the DAE probe connector pins, use great care when installing the probe to the DAE. Carefully connect the probe with the connector notch oriented in the mating position. Avoid any rotational movement of the probe body versus the DAE while turning the locking nut of the connector. The same care shall be used when disconnecting the probe from the DAE.

Schmid & Partner Engineering

TN_BR040315AD DAE4.doc

11.12.2009

Shenzhen Anbotek Compliance Laboratory Limited





Client

FCC ID: Z4TSEEEDAWSBU1

Page52of80

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland

Accredited by the Swiss Accreditation Service (SAS)

Anbotek (Auden)



S Schweizerlscher Kalibrierdienst C Service sulsse d'étalonnage Servizio svizzero di taratura S Swiss Calibration Service

Accreditation No.: SCS 0108

Certificate No: DAE4-387_Sep03

CALIBRATION CERTIFICATE

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Object	DAE4 - SD 000 D04 BM - SN: 387
Calibration procedure(s)	QA CAL-06.v29 Calibration procedure for the data acquisition electronics (DAE)
Calibration date:	September 03, 2019

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration		
Keithley Multimeter Type 2001	SN: 0810278	y Multimeter Type 2001 SN: 0810278 11-Aug-19 (No:21092)		Aug-20	
Secondary Standards	ID #	Check Date (in house)	Scheduled Check		
Auto DAE Calibration Unit	SE UWS 053 AA 1001	05-Jan-19 (in house check)	In house check: Jan-20		
Calibrator Box V2.1	SE UMS 006 AA 1002	05-Jan-19 (in house check)	In house check; Jan-20		
	Name	Function	Signature		
Calibrated by:	Name Dominique Steffen	Function Laboratory Technician	Signature		
Calibrated by: Approved by:	A MARSHAR MARSHAR		Signature		

Certificate No: DAE4-387_Sep03

Page 1 of 5

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: Z4TSEEEDAWSBU1

Page53of80

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdiens Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary

DAE Connector angle

data acquisition electronics information used in DASY system to align probe sensor X to the robot coordinate system.

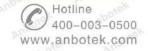
Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a
 result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
 - Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
 - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

Certificate No: DAE4-387_Sep03

Page 2 of 5

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: Z4TSEEEDAWSBU1

Page54of80

DC Voltage Measurement A/D - Converter Resolution nominal

 AVD - Converter Resolution nominal

 High Range:
 1LSB =
 6.1μV ,
 full range =
 -100...+300 mV

 Low Range:
 1LSB =
 61nV ,
 full range =
 -1......+3mV

 DASY measurement parameters:
 Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	x	Y	z
High Range	404.489 ± 0.02% (k=2)	404.852 ± 0.02% (k=2)	404.862 ± 0.02% (k=2)
Low Range	3.97827 ± 1.50% (k=2)	3.95875 ± 1.50% (k=2)	. ,

Connector Angle

Connector Angle to be used in DASY system	53.0 ° ± 1 °

Certificate No: DAE4-387_Sep03

Page 3 of 5

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: Z4TSEEEDAWSBU1

Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range	Reading (µV)	Difference (µV)	Error (%)
Channel X + Input	200032.85	-3.31	-0.00
Channel X + Input	20007.64	1.88	0.01
Channel X - Input	-20003.48	1.18	-0.01
Channel Y + Input	200034.23	-1.43	-0.00
Channel Y + Input	20006.60	0.91	0.00
Channel Y - Input	-20004.04	0.72	-0.00
Channel Z + Input	200035.38	-0.83	-0.00
Channel Z + Input	20003.69	-2.11	-0.01
Channel Z - Input	-20006.38	-1.59	0.01

Low Range	Reading (µV)	Difference (µV)	Error (%)
Channel X + Input	2001.63	0.08	0.00
Channel X + Input	202.29	0.70	0.35
Channel X - Input	-197.90	0.60	-0.30
Channel Y + Input	2001.33	-0.07	-0.00
Channel Y + Input	200.86	-0.60	-0.30
Channel Y - Input	-199.87	-1.23	0.62
Channel Z + Input	2001.61	0.27	0.01
Channel Z + Input	200.60	-0.70	-0.35
Channel Z - Input	-199.51	-0.85	0.43

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (µV)
Channel X	200	13.50	11.56
	- 200	-8.64	-11.18
Channel Y	200	-0.81	-1.28
	- 200	1.05	0.09
Channel Z	200	7.17	6.91
	- 200	-9.46	-9.01

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (µV)	Channel Y (µV)	Channel Z (µV)
Channel X	200	-	-1.70	0.33
Channel Y	200	10.70	-	-0.38
Channel Z	200	7.11	7.89	-

Certificate No: DAE4-387_Sep03

Page 4 of 5

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com

FCC ID: Z4TSEEEDAWSBU1

Page56of80

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15969	17466
Channel Y	15661	16162
Channel Z	15990	16190

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec Input 10M Ω

	Average (µV)	min. Offset (µV)	max. Offset (μV)	Std. Deviation (µV)
Channel X	0.73	-2.58	3.29	0.62
Channel Y	0.41	-0.49	1.23	0.40
Channel Z	-0.80	-1.88	0.30	0.42

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9

Certificate No: DAE4-387_Sep03

Page 5 of 5

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: Z4TSEEEDAWSBU1

Page57of80



Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: Z4TSEEEDAWSBU1

C

S

Page58of80

Calibration Laboratory of Schmid & Partner

Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM x,y,z
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- b) IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010 c) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation:

d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: D5GHzV2-1160_Oct11

Page 2 of 15

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: Z4TSEEEDAWSBU1

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.8
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy = 4.0 mm, dz = 1.4 mm	Graded Ratio = 1.4 (Z direction)
Frequency	5200 MHz ± 1 MHz 5300 MHz ± 1 MHz 5600 MHz ± 1 MHz 5800 MHz ± 1 MHz	

Head TSL parameters at 5200 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	36.0	4.66 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	$36.4\pm6~\%$	4.57 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 "C		

SAR result with Head TSL at 5200 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	8.06 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	80.7 W/kg ± 19.9 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR averaged over 10 cm ³ (10 g) of Head TSL	condition 100 mW input power	2.31 W/kg

Certificate No: D5GHzV2-1160_Oct11 Page 3 of 15

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: Z4TSEEEDAWSBU1

Page60of80

Head TSL parameters at 5300 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.9	4.76 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	36.2 ± 6 %	4.68 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5300 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	8.26 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	82.7 W / kg ± 19.9 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR averaged over 10 cm ³ (10 g) of Head TSL SAR measured	condition 100 mW input power	2.39 W/kg

Head TSL parameters at 5600 MHz

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.5	5.07 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) "C	35.7 ± 6 %	5.03 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5600 MHz

SAR for nominal Head TSL parameters

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	8.69 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	87.0 W/kg ± 19.9 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAH averaged over 10 cm (10 g) of head 15L	condition	
SAR measured	100 mW input power	2.47 W/kg

normalized to 1W

24.7 W/kg ± 19.5 % (k=2)

Certificate No: D5GHzV2-1160_Oct11

Page 4 of 15

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: Z4TSEEEDAWSBU1

Page61of80

Head TSL parameters at 5800 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.3	5.27 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	35.3 ± 6 %	5.26 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5800 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	8.20 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	82.0 W/kg ± 19.9 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	100 mW input power	2.31 W/kg
on thousand		

Certificate No: D5GHzV2-1160_Oct11 Page 5 of 15

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: Z4TSEEEDAWSBU1

Page62of80

Body TSL parameters at 5200 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	49.0	5.30 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) "C	47.9 ± 6 %	5.35 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C		

SAR result with Body TSL at 5200 MHz

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	100 mW input power	7.81 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	77.8 W/kg ± 19.9 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR averaged over 10 cm ³ (10 g) of Body TSL SAR measured	condition 100 mW input power	2.18 W/kg

Body TSL parameters at 5300 MHz

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	48.9	5.42 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	47.7 ± 6 %	5.49 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C		

SAR result with Body TSL at 5300 MHz

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	100 mW input power	7.88 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	78.4 W/kg ± 19.9 % (k=2)
	a condition	
SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR averaged over 10 cm ³ (10 g) of Body TSL SAR measured	condition 100 mW input power	2.20 W/kg
		2.20 W/kg 21.9 W/kg ± 19.5 % (k=2

Certificate No: D5GHzV2-1160_Oct11

Page 6 of 15

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: Z4TSEEEDAWSBU1

46.7 ± 6 %

Page63of80

5.77 mho/m

5.99 mho/m ± 6 %

Body TSL parameters at 5600 MHz

Measured Body TSL parameters

The following parameters and calculations were	applied.	
	Temperature	Permittivity
Nominal Body TSL parameters	22.0 °C	48.5

SAR result with Body TSL at 5600 MHz

Body TSL temperature change during test

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	100 mW input power	8.20 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	81.5 W/kg ± 19.9 % (k=2)
	and dates	
SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR averaged over 10 cm ³ (10 g) of Body TSL SAR measured	condition 100 mW input power	2.30 W/kg

(22.0 ± 0.2) °C

< 0.5 °C

Body TSL parameters at 5800 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	48.2	6.00 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) "C	46.4 ± 6 %	6.27 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C		

SAR result with Body TSL at 5800 MHz

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	100 mW input power	7.88 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	78.3 W/kg ± 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	100 mW input power	2,20 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	21.8 W/kg ± 19.5 % (k=2)

Certificate No: D5GHzV2-1160_Oct11

Page 7 of 15

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: Z4TSEEEDAWSBU1



Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters with Head TSL at 5200 MHz

Impedance, transformed to feed point	48.1 Ω - 8.5 jΩ
Return Loss	- 21.0 dB

Antenna Parameters with Head TSL at 5300 MHz

Impedance, transformed to feed point	50.2 Ω - 5.2 jΩ	
Return Loss	- 25.7 dB	

Antenna Parameters with Head TSL at 5600 MHz

Impedance, transformed to feed point	54,8 Ω - 2.5 jΩ	
Return Loss	- 25.7 dB	

Antenna Parameters with Head TSL at 5800 MHz

Impedance, transformed to feed point	53.0 Ω - 3.0 jΩ
Return Loss	- 27.7 dB

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: Z4TSEEEDAWSBU1

Page65of80

Antenna Parameters with Body TSL at 5200 MHz

Impedance, transformed to feed point	48.6 Ω - 6.8 jΩ
Return Loss	- 23.0 dB

Antenna Parameters with Body TSL at 5300 MHz

Impedance, transformed to feed point	49.0 Ω - 4.2 jΩ
Return Loss	- 27.1 dB

Antenna Parameters with Body TSL at 5600 MHz

Impedance, transformed to feed point	56.2 Ω - 0.7 jΩ
Return Loss	- 24.6 dB

Antenna Parameters with Body TSL at 5800 MHz

Impedance, transformed to feed point	55.9 Ω - 1.7 jΩ
Return Loss	- 24.8 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.199 ns

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	June 06, 2013

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: Z4TSEEEDAWSBU1



DASY5 Validation Report for Head TSL

Date: 24.09.2018

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 5GHz; Type: D5GHzV2; Serial: D5GHzV2 - SN: 1160

Communication System: UID 0 - CW; Frequency: 5200 MHz, Frequency: 5300 MHz, Frequency: 5600 MHz, Frequency: 5800 MHz

Medium parameters used: f = 5200 MHz; σ = 4.57 S/m; ε_r = 36.4; ρ = 1000 kg/m³. Medium parameters used: f = 5300 MHz; σ = 4.68 S/m; ε_r = 36.2; ρ = 1000 kg/m³. Medium parameters used: f = 5600 MHz; σ = 5.03 S/m; ε_r = 35.7; ρ = 1000 kg/m³. Medium parameters used: f = 5800 MHz; σ = 5.26 S/m; ε_r = 35.3; ρ = 1000 kg/m³.

Phantom section: Flat Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: EX3DV4 SN3503; ConvF(5.51, 5.51, 5.51); Calibrated: 30.12.2017, ConvF(5.21, 5.21, 5.21); Calibrated: 30.12.2017, ConvF(4.92, 4.92, 4.92); Calibrated: 30.12.2017, ConvF(4.9, 4.9, 4.9); Calibrated: 30.12.2017,
- Sensor-Surface: 1.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 17.08.2018
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5200 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 64.41 V/m; Power Drift = 0.08 dB Peak SAR (extrapolated) = 29.3 W/kg SAR(1 g) = 8.06 W/kg; SAR(10 g) = 2.31 W/kg Maximum value of SAR (measured) = 18.7 W/kg

Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5300 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 65.31 V/m; Power Drift = 0.05 dB Peak SAR (extrapolated) = 31.1 W/kg SAR(1 g) = 8.26 W/kg; SAR(10 g) = 2.39 W/kg Maximum value of SAR (measured) = 19.4 W/kg

Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5600 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 65.34 V/m; Power Drift = 0.03 dB Peak SAR (extrapolated) = 34.7 W/kg SAR(1 g) = 8.69 W/kg; SAR(10 g) = 2.47 W/kg Maximum value of SAR (measured) = 21.0 W/kg

Certificate No: D5GHzV2-1160_Oct11

Page 10 of 15

Shenzhen Anbotek Compliance Laboratory Limited

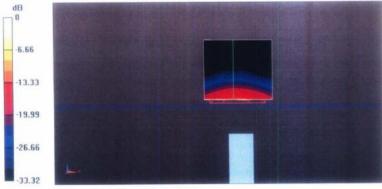




FCC ID: Z4TSEEEDAWSBU1

Page67of80

Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5800 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 62.41 V/m; Power Drift = 0.03 dB Peak SAR (extrapolated) = 34.5 W/kg SAR(1 g) = 8.2 W/kg; SAR(10 g) = 2.31 W/kg Maximum value of SAR (measured) = 20.5 W/kg



0 dB = 18.7 W/kg = 12.72 dBW/kg

Certificate No: D5GHzV2-1160_Oct11 Page 11 of 15

Shenzhen Anbotek Compliance Laboratory Limited

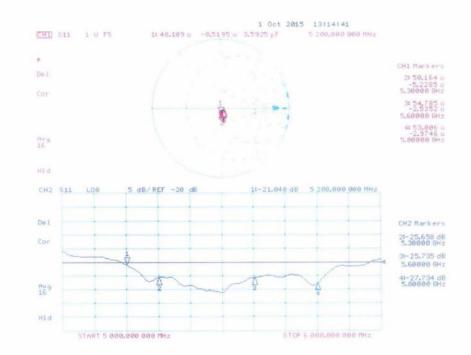
Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com

Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1

Page68of80

Impedance Measurement Plot for Head TSL



Certificate No: D5GHzV2-1160_Oct11 Page 12 of 15

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com



FCC ID: Z4TSEEEDAWSBU1



DASY5 Validation Report for Body TSL

Date: 05.10.2018

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 5GHz; Type: D5GHzV2; Serial: D5GHzV2 - SN: 1160

Communication System: UID 0 - CW; Frequency: 5200 MHz, Frequency: 5300 MHz, Frequency: 5600 MHz, Frequency: 5800 MHz

Medium parameters used: f = 5200 MHz; σ = 5.35 S/m; ϵ_r = 47.9; ρ = 1000 kg/m³, Medium parameters used: f = 5300 MHz; σ = 5.49 S/m; ϵ_r = 47.7; ρ = 1000 kg/m³, Medium parameters used: f = 5600 MHz; σ = 5.99 S/m; ϵ_r = 46.7; ρ = 1000 kg/m³, Medium parameters used: f = 5800 MHz; σ = 6.27 S/m; ϵ_r = 46.4; ρ = 1000 kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: EX3DV4 SN3503; ConvF(4.95, 4.95, 4.95); Calibrated: 30.12.2017, ConvF(4.78, 4.78, 4.78); Calibrated: 30.12.2017; ConvF(4.35, 4.35, 4.35); Calibrated: 30.12.2017, ConvF(4.32, 4.32, 4.32); Calibrated: 30.12.2017;
- Sensor-Surface: 1.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 17.08.2018
- Phantom: Flat Phantom 5.0 (back): Type: QD000P50AA; Serial: 1002
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole Calibration for Body Tissue/Pin=100mW, dist=10mm, f=5200 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 67.32 V/m; Power Drift = -0.04 dB Peak SAR (extrapolated) = 30.4 W/kg SAR(1 g) = 7.81 W/kg; SAR(10 g) = 2.18 W/kg Maximum value of SAR (measured) = 18.2 W/kg

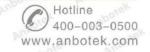
Dipole Calibration for Body Tissue/Pin=100mW, dist=10mm, f=5300 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 67.22 V/m; Power Drift = -0.06 dB Peak SAR (extrapolated) = 31.6 W/kg SAR(1 g) = 7.88 W/kg; SAR(10 g) = 2.2 W/kg Maximum value of SAR (measured) = 18.8 W/kg

Dipole Calibration for Body Tissue/Pin=100mW, dist=10mm, f=5600 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 67.36 V/m; Power Drift = -0.03 dB Peak SAR (extrapolated) = 36.6 W/kg SAR(1 g) = 8.2 W/kg; SAR(10 g) = 2.3 W/kg Maximum value of SAR (measured) = 20.2 W/kg

Certificate No: D5GHzV2-1160_Oct11

Page 13 of 15

Shenzhen Anbotek Compliance Laboratory Limited

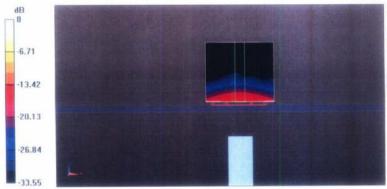




FCC ID: Z4TSEEEDAWSBU1

Page70of80

Dipole Calibration for Body Tissue/Pin=100mW, dist=10mm, f=5800 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 65.22 V/m; Power Drift = -0.03 dB Peak SAR (extrapolated) = 37.1 W/kg SAR(1 g) = 7.88 W/kg; SAR(10 g) = 2.2 W/kg Maximum value of SAR (measured) = 19.7 W/kg



0 dB = 18.2 W/kg = 12.60 dBW/kg

Certificate No: D5GHzV2-1160 Oct11

Page 14 of 15

Shenzhen Anbotek Compliance Laboratory Limited

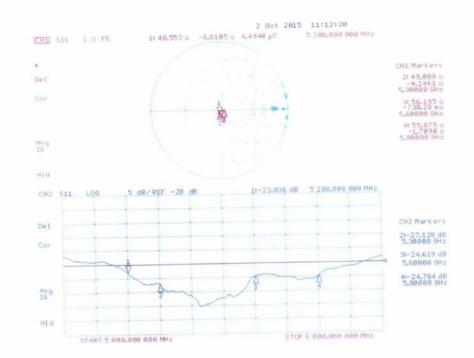
Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com

Report No.: 18220WC00009805

FCC ID: Z4TSEEEDAWSBU1

Page71of80

Impedance Measurement Plot for Body TSL



Certificate No: D5GHzV2-1160_Oct11 Page 15 of 15

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com



Calibration Procedure(s) FD-Z11-2-003-01 Calibration Procedures for dipole validation kits

Jun 15, 2018

Calibration date:

This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements(SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature(22±3)¹ and humidity<70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
Power Meter NRP2	101919	01-Jul-17 (CTTL, No.J17X04256)	Jun-18
Power sensor NRP-Z91	101547	01-Jul-17 (CTTL, No.J17X04256)	Jun-18
Reference Probe EX3DV4	SN 7307	19-Feb-18(SPEAG,No.EX3-7307_Feb18)	Feb-19
DAE4	SN 771	02-Feb-18(CTTL-SPEAG,No.Z18-97011)	Feb-19
Secondary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
Signal Generator E4438C	MY49071430	01-Feb-18 (CTTL, No.J18X00893)	Jan-19
Network Analyzer E5071C	MY46110673	26-Jan-18 (CTTL, No.J18X00894)	Jan-19

	Name	Function	Signature
Calibrated by:	Zhao Jing	SAR Test Engineer	221 -
Reviewed by:	Qi Dianyuan	SAR Project Leader	wor
Approved by:	Lu Bingsong	Deputy Director of the laboratory	-m. 41542
		Issued: Jun 1	7, 2018
This calibration certified	cate shall not be reprodue	ced except in full without written approval o	f the laboratory.

Certificate No: Z18-97091

Page 1 of 8

Shenzhen Anbotek Compliance Laboratory Limited

FCC ID: Z4TSEEEDAWSBU1



In Collaboration with
SDEAG

 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2079
 Fax: +86-10-62304633-2504

 E-mail: ettl@chinattl.com
 Http://www.chinattl.cn

Glossary:

Anbotek

Product Safety

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORMx,y,z
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) For hand-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)", February 2005
- c) IEC 62209-2, "Procedure to measure the Specific Absorption Rate (SAR) For wireless communication devices used in close proximity to the human body (frequency range of 30MHz to 6GHz)", March 2010
- d) KDB865664, SAR Measurement Requirements for 100 MHz to 6 GHz

Additional Documentation:

e) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end
 of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed
 point exactly below the center marking of the flat phantom section, with the arms oriented
 parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole
 positioned under the liquid filled phantom. The impedance stated is transformed from the
 measurement at the SMA connector to the feed point. The Return Loss ensures low
 reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

She Certificate No: Z18-97091

Page 2 of 8

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com

Hotline 400-003-0500 www.anbotek.com

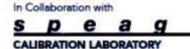
Page73of80

Report No.: 18220WC00009805



Page74of80





 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2079
 Fax: +86-10-62304633-2504

 E-mail: cttl@chinattl.com
 Http://www.chinattl.cn

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY52	52.8.8.1258
Extrapolation	Advanced Extrapolation	
Phantom	Triple Flat Phantom 5.1C	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	2450 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	39.2	1.80 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	39.0 ± 6 %	1.77 mho/m ± 6 %
Head TSL temperature change during test	<1.0 °C		

SAR result with Head TSL

SAR averaged over 1 cm^3 (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	13.0 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	52.4 mW /g ± 20.8 % (k=2)
SAR averaged over 10 cm^3 (10 g) of Head TSL	Condition	
SAR measured	250 mW input power	6.06 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	24.3 mW /g ± 20.4 % (k=2)

Body TSL parameters

The following parameters and calculations were applied.

10217	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	52.7	1.95 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	52.9 ± 6 %	1.97 mho/m ± 6 %
Body TSL temperature change during test	<1.0 °C		

SAR result with Body TSL

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	13.0 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	51.8 mW /g ± 20.8 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Body TSL	Condition	
SAR measured	250 mW input power	6.18 mW/g
SAR for nominal Body TSL parameters	normalized to 1W	24.7 mW /g ± 20.4 % (k=2)

Shenz Certificate No: Z18-97091

Page 3 of 8



FCC ID: Z4TSEEEDAWSBU1

Page75of80



e р CALIBRATION LABORATORY

Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2079 Fax: +86-10-62304633-2504 E-mail: ettl@chinattl.com Http://www.chinattl.en

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	54.6Ω+ 2.77jΩ	
Return Loss	- 25.8dB	

Antenna Parameters with Body TSL

Impedance, transformed to feed point	50.7Ω+ 4.28jΩ	
Return Loss	- 27.3dB	

General Antenna Parameters and Design

ļ	Electrical Delay (one direction)	1.263 ns

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Contraction of the second se	A CONTRACTOR OF

Certificate No: Z18-97091

Page 4 of 8

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: Z4TSEEEDAWSBU1





Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2079 Fax: +86-10-62304633-2504 E-mail: ettl@chinattl.com Http://www.chinattl.en

DASY5 Validation Report for Head TSL Test Laboratory: CTTL, Beijing, China

Date: 06.15.2018

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN: 910

Communication System: UID 0, CW; Frequency: 2450 MHz; Duty Cycle: 1:1 Medium parameters used: f = 2450 MHz; $\sigma = 1.767$ S/m; $\epsilon r = 39.01$; $\rho = 1000$ kg/m3 Phantom section: Right Section

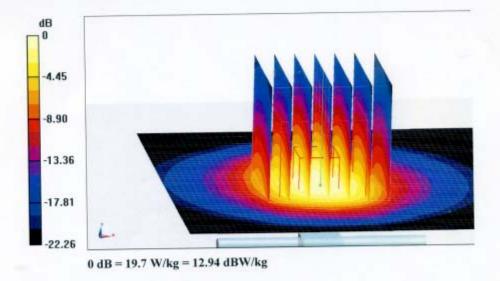
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007) DASY5 Configuration:

- Probe: EX3DV4 SN7307; ConvF(7.36, 7.36, 7.36); Calibrated: 2/19/2018;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn771; Calibrated: 2018-02-02
- Phantom: Triple Flat Phantom 5.1C; Type: QD 000 P51 CA; Serial: 1161/1
- Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7372)

Dipole Calibration/Zoom Scan (7x7x7) (7x7x7)/Cube 0: Measurement grid: dx=5mm,

dy=5mm, dz=5mm

Reference Value = 106.5 V/m; Power Drift = 0.02 dB Peak SAR (extrapolated) = 26.7 W/kg SAR(1 g) = 13 W/kg; SAR(10 g) = 6.06 W/kg Maximum value of SAR (measured) = 19.7 W/kg



Certificate No: Z18-97091

Page 5 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



FCC ID: Z4TSEEEDAWSBU1

Page77of80

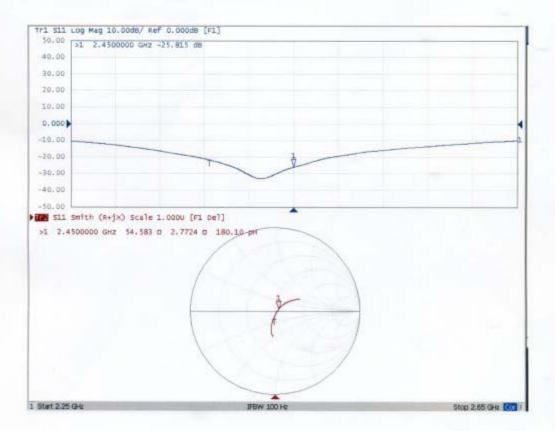


 Add: No.51 Xueyuan Road, Haidian District, Beljing, 100191, China

 Tel: +86-10-62304633-2079
 Fax: +86-10-62304633-2504

 E-mail: cttl@chinattLcom
 Http://www.chinattl.cn

Impedance Measurement Plot for Head TSL



Certificate No: Z18-97091

Page 6 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



FCC ID: Z4TSEEEDAWSBU1





Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2079 Fax: +86-10-62304633-2504 E-mail: ettl@chinattl.com Http://www.chinattl.en

DASY5 Validation Report for Body TSL

Date: 06.15.2018

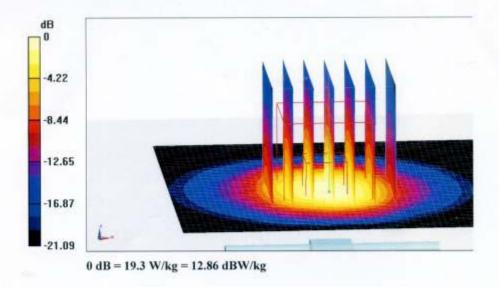
Test Laboratory: CTTL, Beijing, China **DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN: 910** Communication System: UID 0, CW; Frequency: 2450 MHz; Duty Cycle: 1:1 Medium parameters used: f = 2450 MHz; σ = 1.972 S/m; ε_r = 52.92; ρ = 1000 kg/m³ Phantom section: Center Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007) DASY5 Configuration:

- Probe: EX3DV4 SN7307; ConvF(7.22, 7.22, 7.22); Calibrated: 2/19/2018;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn771; Calibrated: 2018-02-02
- Phantom: Triple Flat Phantom 5.1C; Type: QD 000 P51 CA; Serial: 1161/1
- Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7372)

Dipole Calibration/Zoom Scan (7x7x7) (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 98.89 V/m; Power Drift = 0.03 dB Peak SAR (extrapolated) = 25.6 W/kg SAR(1 g) = 13 W/kg; SAR(10 g) = 6.18 W/kg Maximum value of SAR (measured) = 19.3 W/kg



Certificate No: Z18-97091

Page 7 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



FCC ID: Z4TSEEEDAWSBU1

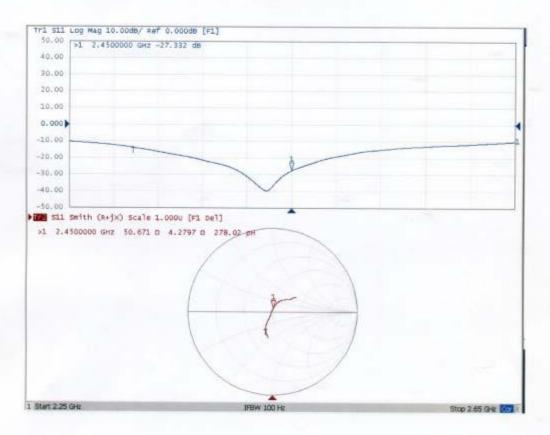


 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2079
 Fax: +86-10-62304633-2504

 E-mail: cttl@chinattl.com
 Http://www.chinattl.cn

Impedance Measurement Plot for Body TSL



Certificate No: Z18-97091

Page 8 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com Hotline 400-003-0500 www.anbotek.com

Page79of80

*****END OF REPORT****

FCC ID: Z4TSEEEDAWSBU1

Page80of80

Anbotek

Product Safety

Report No.: 18220WC00009805

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com